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Vishay Siliconix

Dual P-Channel 20 V (D-S) MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	-20				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.058				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -2.5 \text{ V}$	0.094				
Q _g typ. (nC)	8				
I _D (A) a, e	-4				
Configuration	Dual				

FEATURES

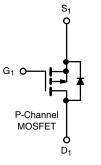
- TrenchFET® power MOSFET
- 100 % R_g and UIS tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

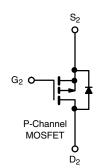


RoHS COMPLIANT HALOGEN **FREE**

APPLICATIONS

- · Load switch
- DC/DC converter





ORDERING INFORMATION				
Package	SO-8			
Lead (Pb)-free	Si9933CDY-T1-E3			
Lead (Pb)-free and halogen-free	Si9933CDY-T1-GE3			

ABSOLUTE MAXIMUM RATINGS (TA)	= 25 °C, unless other	wise noted)			
PARAMETER	SYMBOL LIMIT		UNIT		
Drain-source voltage		V_{DS}	-20	V	
Gate-source voltage	V_{GS}	± 12	7 v		
-	T _C = 25 °C		-4 ^e		
Continuous dusin surrent /T 150 °C\	T _C = 70 °C	1 . 1	-4 ^e		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	l _D	-4 b, c, e	•	
	T _A = 70 °C	† †	-3.8 b, c		
Pulsed drain current (10 µs pulse width)	I _{DM}	-20	A		
Source-drain current diode current	T _C = 25 °C	I _S	-2.5		
Source-drain current diode current	T _A = 25 °C		-1.7 ^{b, c}		
Single pulse avalanche current	. 0.1!!	I _{AS}	-6		
Single-pulse avalanche energy	L = 0.1 mH	E _{AS}	1.8	mJ	
	T _C = 25 °C	P _D	3.1		
Maximum power dissipation	T _C = 70 °C		2] w	
	T _A = 25 °C		2 b, c] vv	
	T _A = 70 °C		1.28 ^{b, c}		
Operating junction and storage temperature range	T _J , T _{stg}	-50 to +150	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT		UNIT	
		STIVIBOL	TYPICAL	MAXIMUM	UNII	
Maximum junction-to-ambient b, d	t ≤ 10 s	R _{thJA}	52	62.5	°C/W	
Maximum junction-to-foot (drain)	Steady state	R _{thJF}	32	40	C/W	

Notes

- a. Based on T_C = 25 °C b. Surface mounted on 1" x 1" FR4 board
- t = 10 s
- d. Maximum under steady state conditions is 110 °C/W
- e. Package limited



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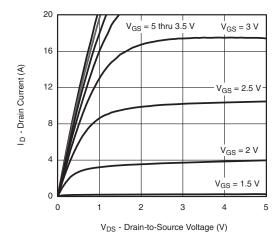
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.A	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = -250 μA	-	-19	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	3.1	-		
Gate threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.6	-	-1.4	V	
Gate-body leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	=	-100	nA	
Zara sata valtasa duain avuvent	,	V _{DS} = -20 V, V _{GS} = 0 V	-	=	-1	μА	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-10		
On-state drain current b	I _{D(on)}	$V_{DS} = \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	-20	-	-	Α	
Drain agures an atata registance h	D	$V_{GS} = -4.5 \text{ V}, I_D = -4.8 \text{ A}$	-	0.048	0.058		
Drain-source on-state resistance ^b	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -1 \text{ A}$	-	0.075	0.094	Ω	
Forward transconductance b	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -4.8 \text{ A}$	-	11	-	S	
Dynamic ^a							
Input capacitance	C _{iss}		-	665	-		
Output capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	140	-	pF	
Reverse transfer capacitance	C _{rss}		-	115	-		
Total gate charge	Q _g	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -4.8 \text{ A}$	-	17	26		
			-	8	12		
Gate-source charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4.8 \text{ A}$	-	2	-	nC -	
Gate-drain charge	Q _{gd}		-	3	-		
Gate resistance	R_g	f = 1 MHz	1.2	6	12	Ω	
Turn-on delay time	t _{d(on)}		-	6	12		
Rise time	t _r	V_{DD} = -10 V, R_L = 2.6 Ω	-	15	23		
Turn-off delay time	t _{d(off)}	$I_D\cong$ -3.8 A, V_{GEN} = -10 V, R_g = 1 Ω	-	26	39		
Fall time	t _f		-	9	18		
Turn-on delay time	t _{d(on)}		-	21	32	ns	
Rise time	t _r	V_{DD} = -10 V, R_L = 2.6 Ω	-	50	75		
Turn-off delay time	t _{d(off)}	$I_D\cong$ -3.8 A, V_{GEN} = -4.5 V, R_g = 1 Ω	-	29	44	1	
Fall time	t _f		-	13	20	1	
Drain-Source Body Diode Characteris	tics						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	-2.5	^	
Pulse diode forward current ^a	I _{SM}		-	-	-20	Α	
Body diode voltage	V _{SD}	I _S = -3.8 A	-	-0.77	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	30	45	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = -3.8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	17	26	nC	
Reverse recovery fall time	t _a	T _J = 25 °C		16	-		
Reverse recovery rise time	t _b			14	-	ns	

Notes

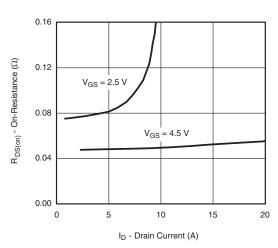
- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

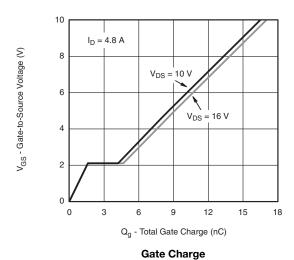




Output Characteristics

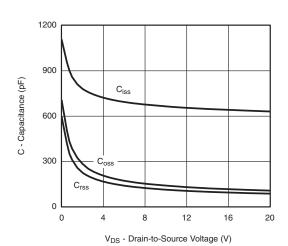


On-Resistance vs. Drain Current and Gate Voltage

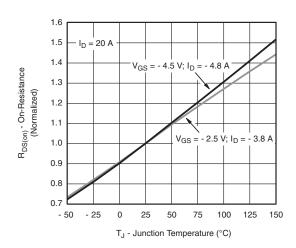


3.0 2.5 I_D - Drain Current (A) 2.0 T_C = 25 °C 1.0 0.5 55 °C 0.0 0.0 0.5 1.0 1.5 2.0 2.5 V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics

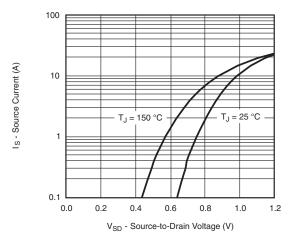


Capacitance

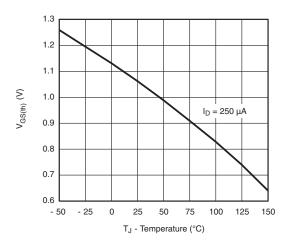


On-Resistance vs. Junction Temperature

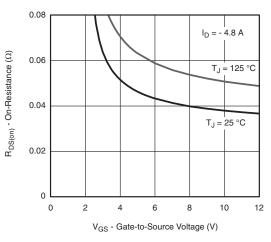




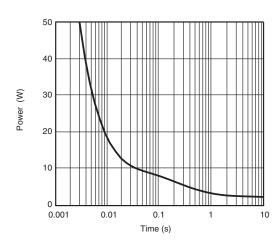
Source-Drain Diode Forward Voltage



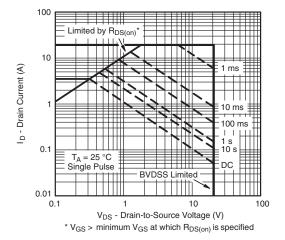
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

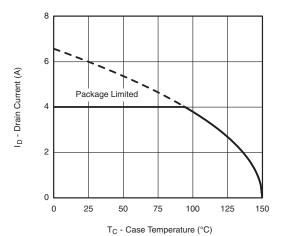


Single Pulse Power, Junction-to-Ambient

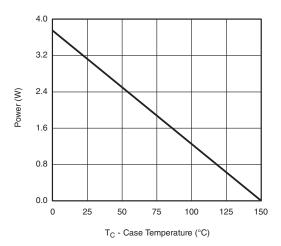


Safe Operating Area, Junction-to-Ambient

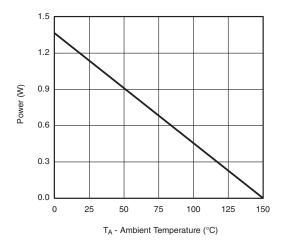




Current Derating a



Power Derating, Junction-to-Foot

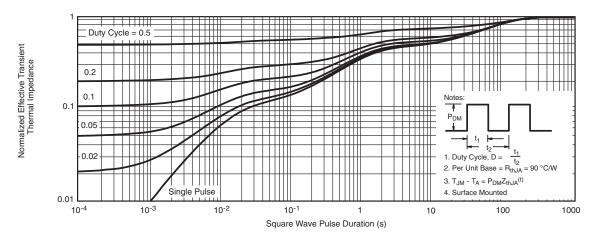


Power Derating, Junction-to-Ambient

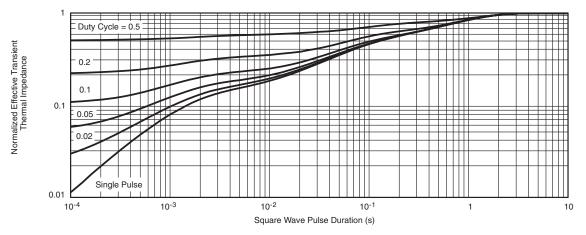
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68791.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018 0.026			
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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